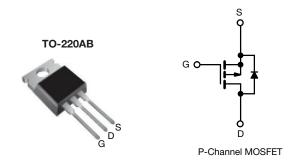
Vishay Siliconix

# **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	-200			
$R_{DS(on)}$ max. ( $\Omega$ )	$V_{GS} = -10 \text{ V}$	0.80		
Q <sub>g</sub> max. (nC)	29			
Q <sub>gs</sub> (nC)	5.4			
Q <sub>gd</sub> (nC)	15			
Configuration	Single			



### **FEATURES**

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- P-channel
- · Fast switching
- Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

## Note

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details.

## **DESCRIPTION**

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF9630PbF		
Lead (PD)-free	SiHF9630-E3		
SnPb	IRF9630		
SIPO	SiHF9630		

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	-200		
Gate-Source Voltage			$V_{GS}$	± 20	V	
Continuous Drain Current	V <sub>GS</sub> at -10 V	T <sub>C</sub> = 25 °C		-6.5		
		T <sub>C</sub> = 100 °C	I <sub>D</sub>	-4.0	Α	
Pulsed Drain Current a			I <sub>DM</sub>	-26		
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy b			E <sub>AS</sub>	500	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	-6.4	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	7.4	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			$P_{D}$	74	W	
Peak Diode Recovery dV/dt c			dV/dt	-5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	00	
Soldering Recommendations (Peak temperature) d for 10 s			_	300	°C	
Mounting Toyour	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = -50$  V, starting  $T_J = 25$  °C, L = 17 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = -6.5$  A (see fig. 12). c.  $I_{SD} \le -6.5$  A, dl/dt  $\le 120$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C. d. 1.6 mm from case.



# Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.7		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					Į.		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	) V, I <sub>D</sub> = -250 μA	-200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = -1 mA	-	-0.24	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	' <sub>GS</sub> , I <sub>D</sub> = -250 μA	-2.0	-	-4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	Vo	$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
Zan Oala Valla a Buria Oamal		$V_{DS} = -200 \text{ V}, V_{GS} = 0 \text{ V}$		-	-	-100	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -160 \text{ V},$	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	-500	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V	I <sub>D</sub> = -3.9 A <sup>b</sup>	-	-	0.80	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = -5$	60 V, I <sub>D</sub> = -3.9 A <sup>b</sup>	2.8	-	-	S
Dynamic						•	
Input Capacitance	C <sub>iss</sub>	,	$I_{GS} = 0 \text{ V},$	-	700	-	pF
Output Capacitance	C <sub>oss</sub>	V	os = -25 V,	-	200	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0	MHz, see fig. 5	-	40	-	
Total Gate Charge	Qg		I <sub>D</sub> = -6.5 A,	-	-	29	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = -10 V	V <sub>DS</sub> = -160 V, see fig. 6 and 13 b	-	-	5.4	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	-	15	
Turn-On Delay Time	t <sub>d(on)</sub>			-	12	-	
Rise Time	t <sub>r</sub>	$V_{DD} = -100 \text{ V, } I_D = -6.5 \text{ A,}$ $R_g = 12 \ \Omega, \ R_D = 15 \ \Omega, \ \text{see fig. } 10^\text{ b}$		-	27	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	28	-	
Fall Time	t <sub>f</sub>			-	24	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from		-	4.5	-	-11
Internal Source Inductance	L <sub>S</sub>	package and ce die contact	package and center of die contact		7.5	-	- nH
Gate Input Resistance	Rg	f = 1 MHz, open drain		0.6	-	3.7	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbo	MOSFET symbol showing the			-6.5	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p -n junction diode		-	-	-26	A
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25  ^{\circ}\text{C},  I_S = -6.5  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$		-	-	-6.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = -6.5 \text{ A}, dI/dt = 100 \text{ A/}\mu\text{s}^{\text{b}}$		-	200	300	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	1.9	2.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turr	n-on time is negligible (turn	on is do	minated b	v Le and	L <sub>D</sub> )

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

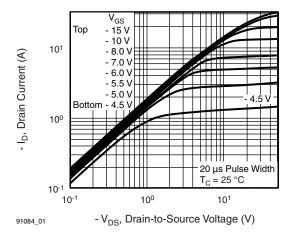


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

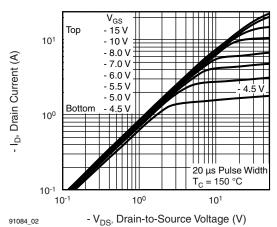


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

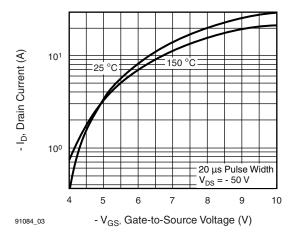


Fig. 3 - Typical Transfer Characteristics

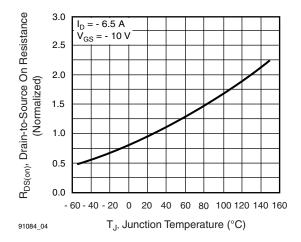


Fig. 4 - Normalized On-Resistance vs. Temperature

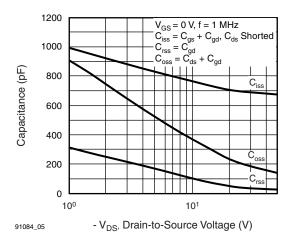


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

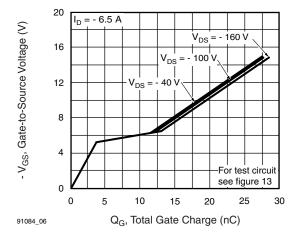


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



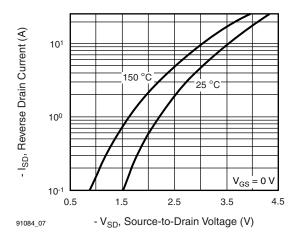


Fig. 7 - Typical Source-Drain Diode Forward Voltage

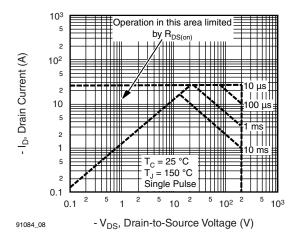


Fig. 8 - Maximum Safe Operating Area

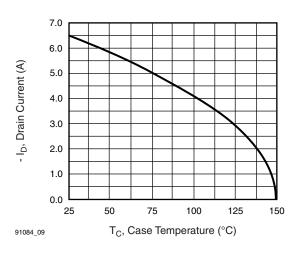


Fig. 9 - Maximum Drain Current vs. Case Temperature

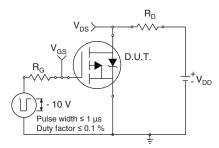


Fig. 10a - Switching Time Test Circuit

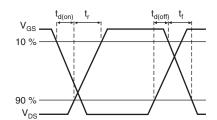


Fig. 10b - Switching Time Waveforms

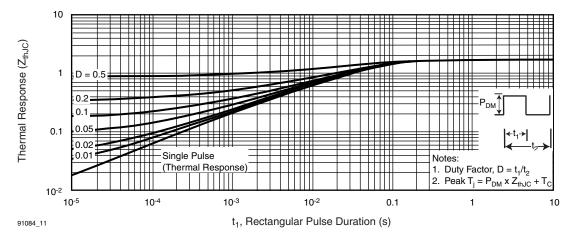


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



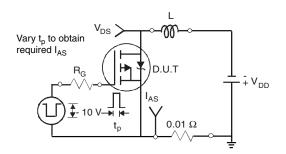


Fig. 12a - Unclamped Inductive Test Circuit

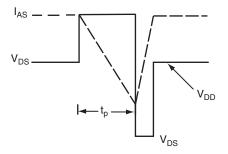


Fig. 12b - Unclamped Inductive Waveforms

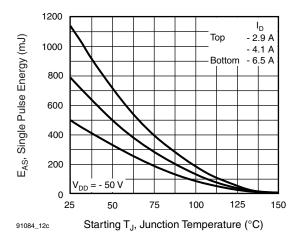


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

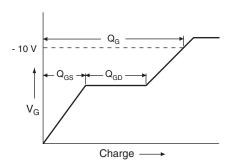


Fig. 13a - Basic Gate Charge Waveform

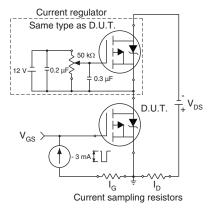
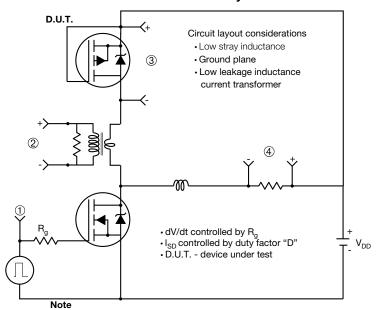


Fig. 13c - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

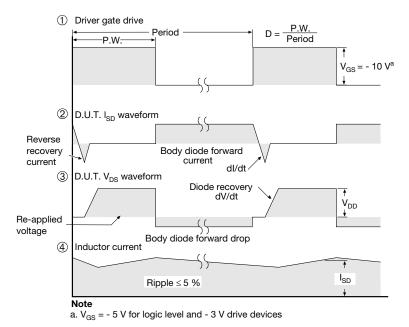
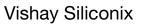


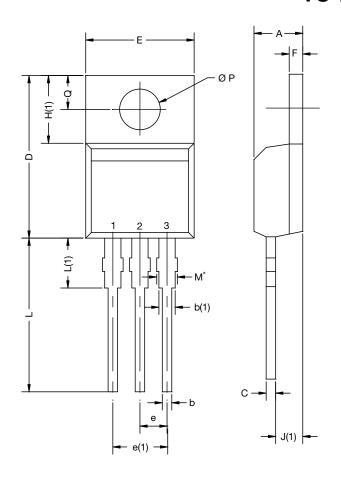
Fig. 14 - For P-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?91084">www.vishay.com/ppg?91084</a>.





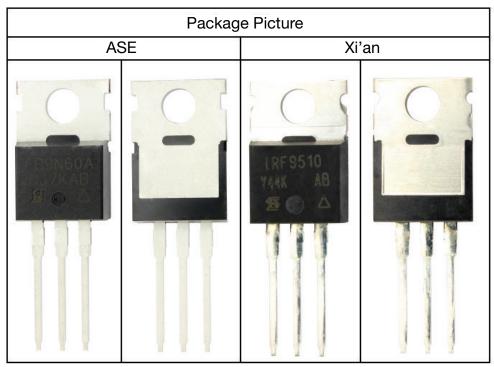
# TO-220-1



DIM.	MILLIM	IETERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
E	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØΡ	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031					

## Note

 $\bullet$   $M^{\star}=0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



# **Legal Disclaimer Notice**

Vishay

## **Disclaimer**

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.

Revision: 13-Jun-16 1 Document Number: 91000